

<b>Notice of References Cited</b>	Application/Control No. 10/567,353		Applicant(s)/Patent Under Reexamination STRADELLA ET AL.	
	Examiner LIEN TM NGO		Art Unit 3754	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,687,710	11-1997	Ambrosio et al.	128/203.15
*	B	US-6,234,168	05-2001	Bruna, Pascal	128/203.12
*	C	US-7,448,342	11-2008	Von Schuckmann, Alfred	116/307
*	D	US-7,195,134	03-2007	Ouyang et al.	222/36
*	E	US-6,328,037	12-2001	Scarrott et al.	128/205.23
*	F	US-6,164,494	12-2000	Marelli, Andrea	222/38
*	G	US-6,161,724	12-2000	Blacker et al.	222/23
*	H	US-7,156,258	01-2007	Eckert, Thomas	222/23
*	I	US-6,065,471	05-2000	Schaeffer et al.	128/203.15
*	J	US-5,988,496	11-1999	Bruna, Pascal	235/91R
*	K	US-6,321,747	11-2001	Dmitrovic et al.	128/203.15
*	L	US-2006/0278225	12-2006	MacMichael et al.	128/205.16
*	M	US-2004/0250812	12-2004	Davies et al.	128/200.14

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.